

## Product Summary

$V_{DS}$	1200 V
$I_D$ ( $T_C=25^\circ\text{C}$ )	36 A
$R_{DS(\text{on}),\text{typ}}$	65 m $\Omega$ @ $V_{GS}=18\text{V}$

## Features

- Low On-Resistance with High Blocking Voltage
- Low Capacitance
- Avalanche Ruggedness
- Halogen Free, RoHS Compliant

## Benefits

- High Frequency Operation
- Enabling Higher Switching Frequency
- Increased Power Density
- Reduction of Heat Sink Requirements

## Applications

- Switch Mode Power Supplies (SMPS)
- Power Inverter & Solar Inverter
- Motor Drivers & EV Charging Station
- DC/DC Converter

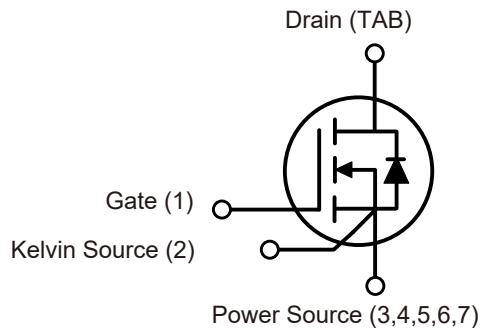
## Package Pin Definitions

- TAB - Drain
- Pin1 - Gate
- Pin2 - Kelvin Source
- Pin3,4,5,6,7 - Power Source

## Package Parameters

Part Number	Marking	Package
B2M065120R	B2M065120R	TO-263-7

## Package: TO-263-7



### Maximum Ratings

Symbol	Parameter	Test conditions	Value	Unit
$V_{DSmax}$	Drain-Source Voltage	$V_{GS}=0V, I_D=100\mu A$	1200	V
$V_{GSmax}^{1)}$	Gate-Source Voltage		-8/22	V
$V_{GSop}$	Recommend Gate-Source Voltage		-4/18	V
$I_D$	Continuous Drain Current	$V_{GS}=18V, T_c=25^\circ C$	36	A
		$V_{GS}=18V, T_c=100^\circ C$	24	A
$I_{D,pulse}$	Pulsed Drain Current	Pulse with $t_p$ limited by $T_{jmax}$	85	A
$P_{tot}$	Power Dissipation	$T_c=25^\circ C, T_j=175^\circ C$	150	W
$T_j$	Operating Junction Temperature		-55~175	°C
$T_{stg}$	Storage Temperature		-55~175	°C

1) Note: When using MOSFET Body Diode  $V_{GSmax}=-4/22V$

### Electrical Characteristics (Defined at $T_j=25^\circ C$ unless otherwise specified)

#### Static Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=100\mu A$	1200			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=5mA$	2.3	2.8	3.5	V
		$V_{GS}=V_{DS}, I_D=5mA, T_j=175^\circ C$		1.9		
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=18V, V_{DS}=0V$			100	nA
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=1200V, V_{GS}=0V$		1	50	$\mu A$
		$V_{DS}=1200V, V_{GS}=0V, T_j=175^\circ C$		10	200	
$R_{DS(on)}$	Drain-Source On-State Resistance	$V_{GS}=18V, I_D=20A$		65	90	$m\Omega$
		$V_{GS}=18V, I_D=20A, T_j=175^\circ C$		110		
$g_{fs}$	Transconductance	$V_{DS}=10V, I_D=20A$		8.5		S

**Thermal Characteristics**

Symbol	Parameter	Value			Unit
		Min.	Typ.	Max.	
$R_{th(jc)}$	Thermal Resistance from Junction to Case		1.0		K/W

**AC Characteristics**

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$C_{iss}$	Input Capacitance	$V_{GS}=0V, V_{DS}=800V$ $f=1MHz, V_{AC}=25mV$		1300		pF
$C_{oss}$	Output Capacitance			75		pF
$C_{rss}$	Reverse Transfer Capacitance			3		pF
$R_{G(int)}$	Internal Gate Resistance	$f=1MHz, V_{AC}=25mV$		1.8		$\Omega$

**Gate Charge Characteristics**

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$Q_{GS}$	Gate to Source Charge	$V_{DS}=800V$ $I_D=20A$ $V_{GS}=-4/+18V$		18		nC
$Q_{GD}$	Gate to Drain Charge			30		nC
$Q_G$	Total Gate Charge			60		nC

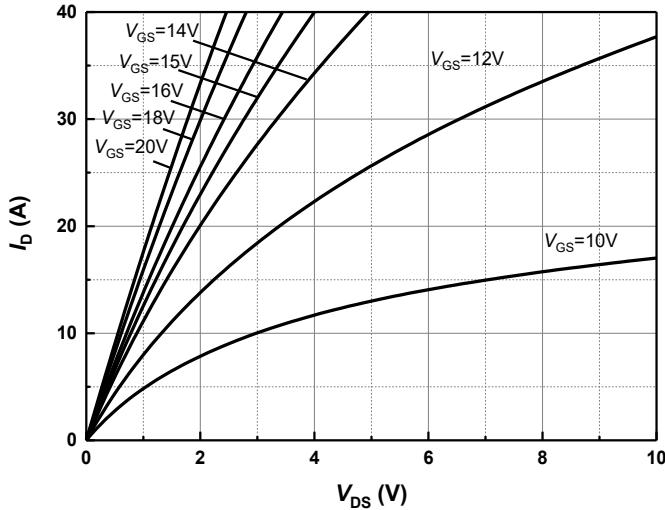
**Switching Characteristics**

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$t_{d(on)}$	Turn-On Delay Time	$V_{DC}=800V, V_{GS}=-4/18V$ $I_D=20A, R_{G(ext)}=8.2\Omega$ $L_o=80nH, T_j=25^\circ C$ diode: body diode at $V_{GS}=-4V$ Inductive Load Eon includes diode reverse recovery		8		ns
$t_r$	Rise Time			30		ns
$t_{d(off)}$	Turn-Off Delay Time			21		ns
$t_f$	Fall Time			12		ns
$E_{on}$	Turn-On Energy			290		uJ
$E_{off}$	Turn-Off Energy			80		uJ
$t_{d(on)}$	Turn-On Delay Time	$V_{DC}=800V, V_{GS}=-4/18V$ $I_D=20A, R_{G(ext)}=8.2\Omega$ $L_o=80nH, T_j=175^\circ C$ diode: body diode at $V_{GS}=-4V$ Inductive Load Eon includes diode reverse recovery		8		ns
$t_r$	Rise Time			30		ns
$t_{d(off)}$	Turn-Off Delay Time			24		ns
$t_f$	Fall Time			12		ns
$E_{on}$	Turn-On Energy			310		uJ
$E_{off}$	Turn-Off Energy			90		uJ

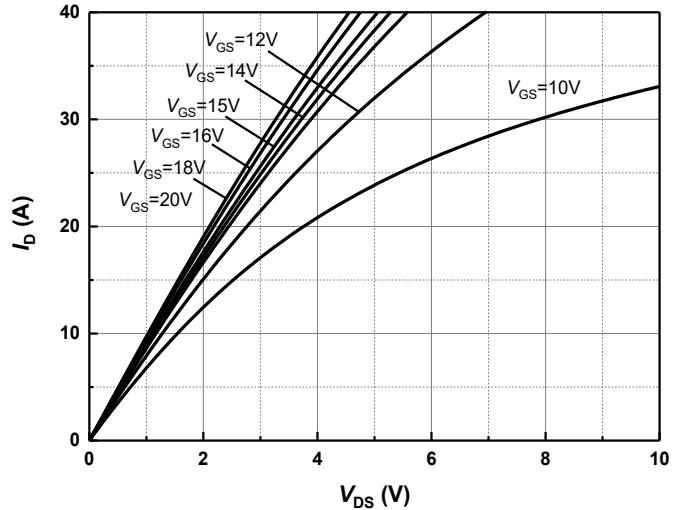
**Reverse Diode Characteristics**

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$V_{SD}$	Diode Forward Voltage	$V_{GS}=-4V, I_{SD}=10A, T_j=25^\circ C$		4.4		V
		$V_{GS}=-4V, I_{SD}=10A, T_j=175^\circ C$		3.7		
$I_{SD}$	Continuous Diode Forward Current	$V_{GS}=-4V, T_c=25^\circ C$			27	A
$I_{SD,pulse}$	Pulse Diode Current	$V_{GS}=-4V$ , pulse width $t_p$ limited by $T_{jmax}$		90		A
$t_{rr}$	Reverse Recovery Time	$V_{DC}=800V, I_{SD}=20A$ $-di_F/dt=2200A/\mu s$ $T_j=25^\circ C$		15		ns
$Q_{rr}$	Reverse Recovery Charge			155		nC
$I_{rrm}$	Peak Reverse Recovery Current			17		A
$t_{rr}$	Reverse Recovery Time	$V_{DC}=800V, I_{SD}=20A$ $-di_F/dt=2200A/\mu s$ $T_j=175^\circ C$		20		ns
$Q_{rr}$	Reverse Recovery Charge			432		nC
$I_{rrm}$	Peak Reverse Recovery Current			32		A

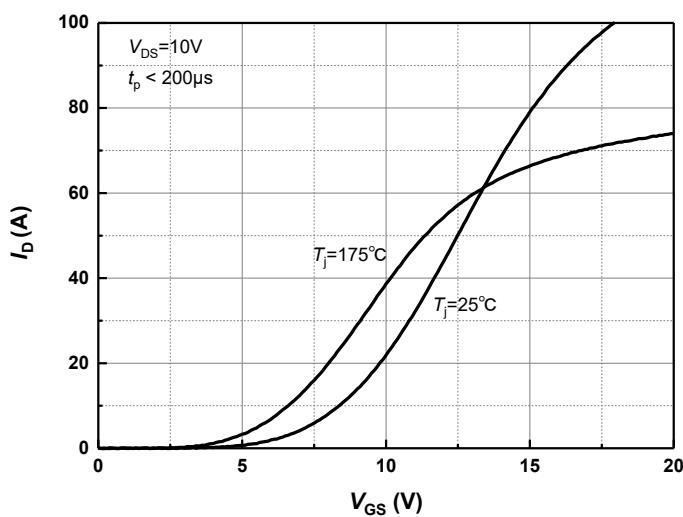
### Typical Performance



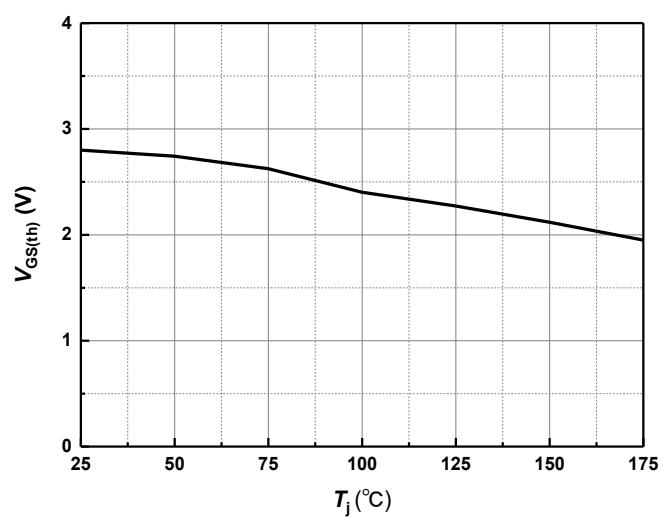
**Figure 1** Typical Forward Output Characteristics at  $T_j = 25^\circ\text{C}$



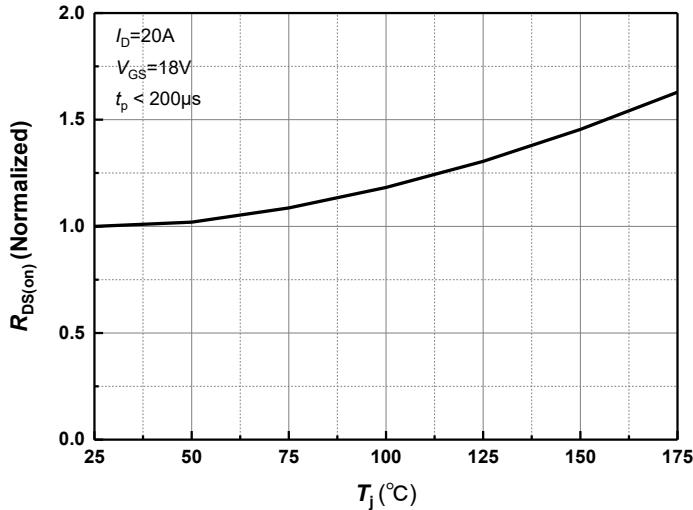
**Figure 2** Typical Forward Output Characteristics at  $T_j = 175^\circ\text{C}$



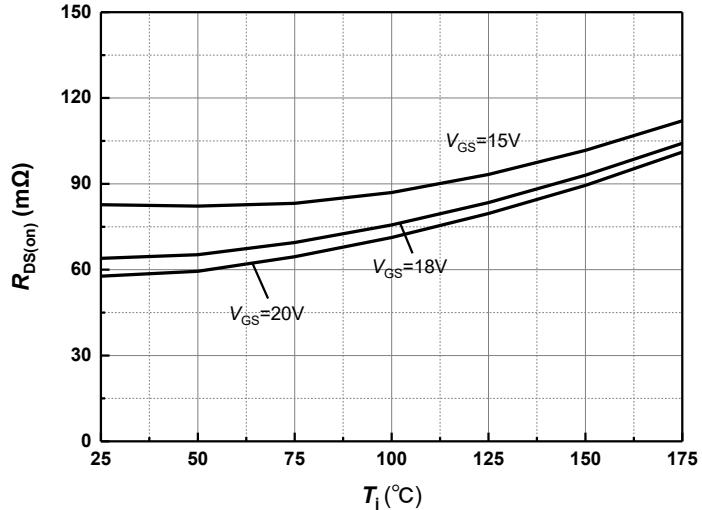
**Figure 3** Transfer Characteristics for Various Temperature



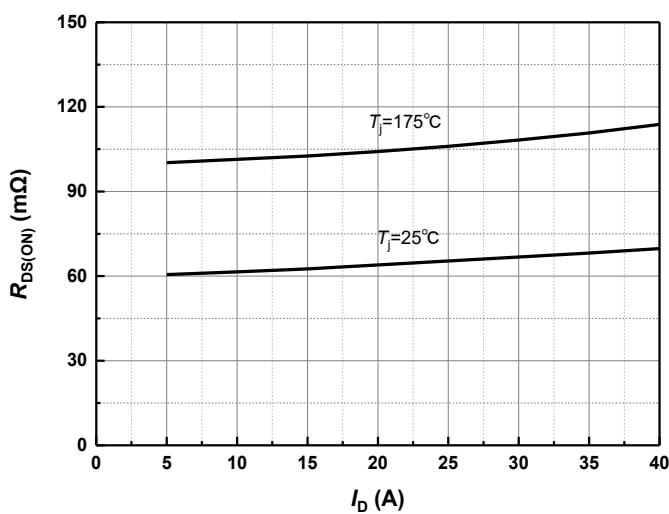
**Figure 4** Threshold Voltage for Various Temperature

**Typical Performance**


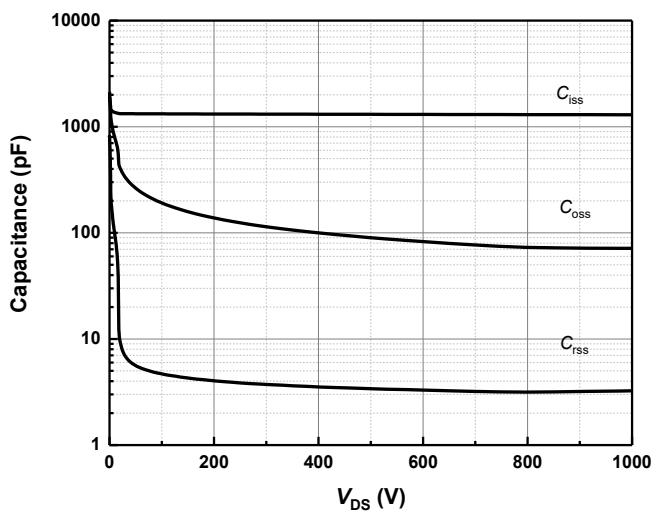
**Figure 5** Normalized On-Resistance for Various Temperature



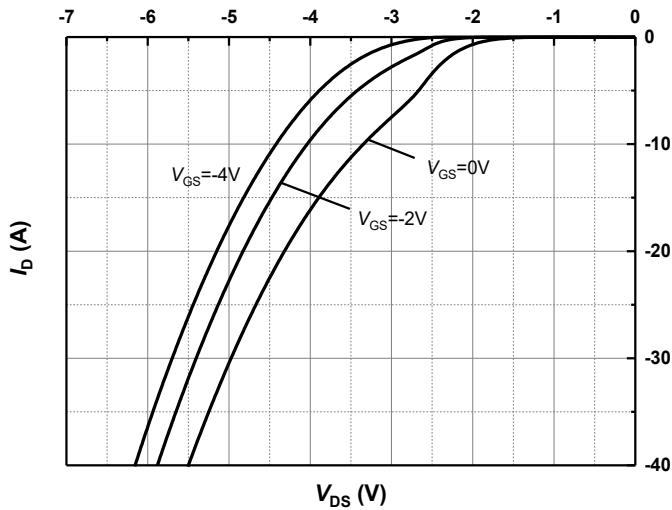
**Figure 6** On-Resistance vs. Temperature for Various Gate-Source Voltage



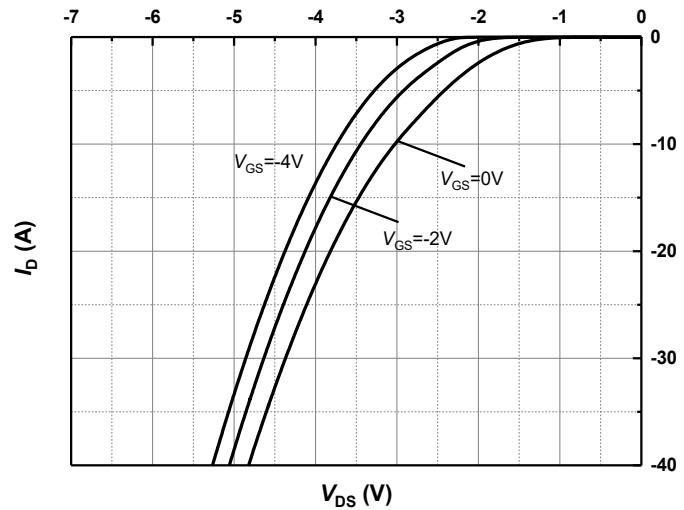
**Figure 7** On-Resistance vs. Drain Current for Various Temperature



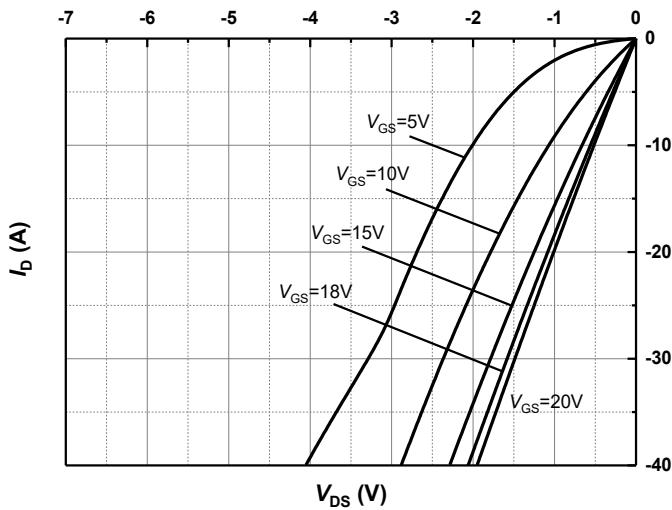
**Figure 8** Capacitance vs. Drain-Source Voltage (0 - 1000V)

**Typical Performance**


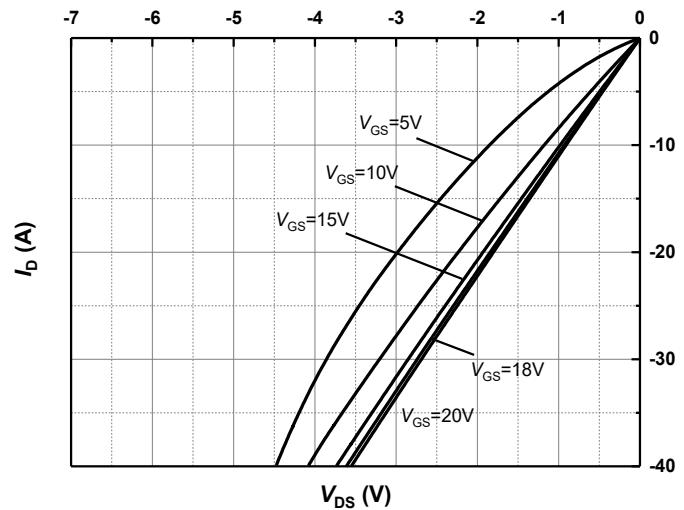
**Figure 9**    **Body Diode Characteristics at  $T_j=25^\circ\text{C}$**



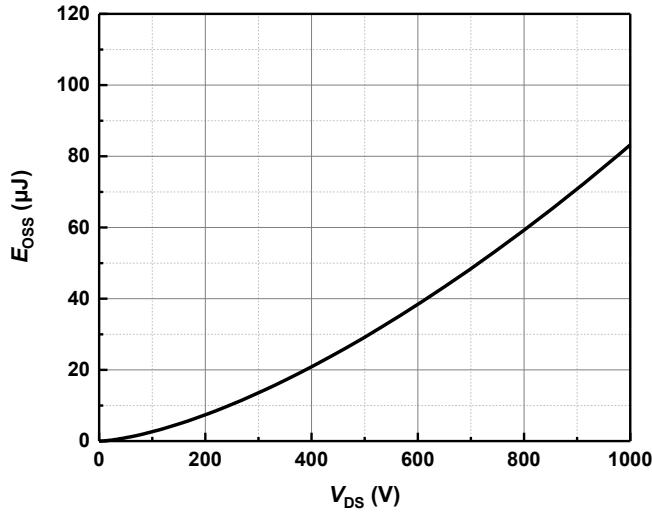
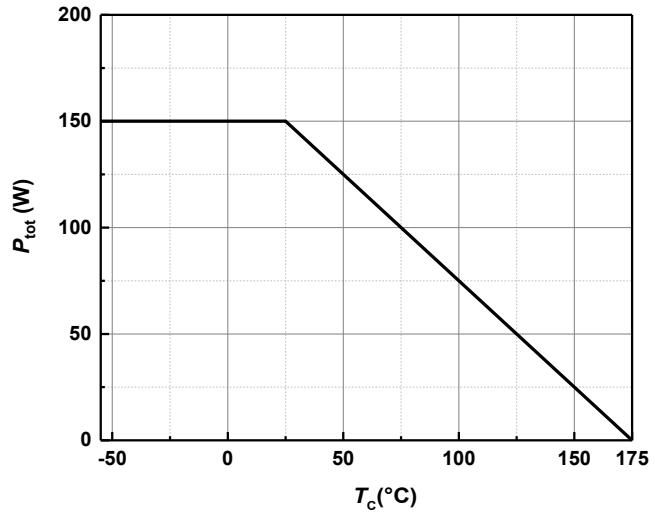
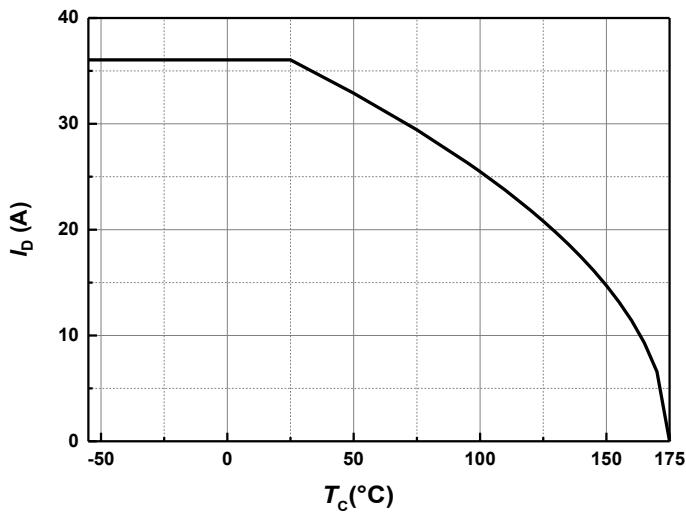
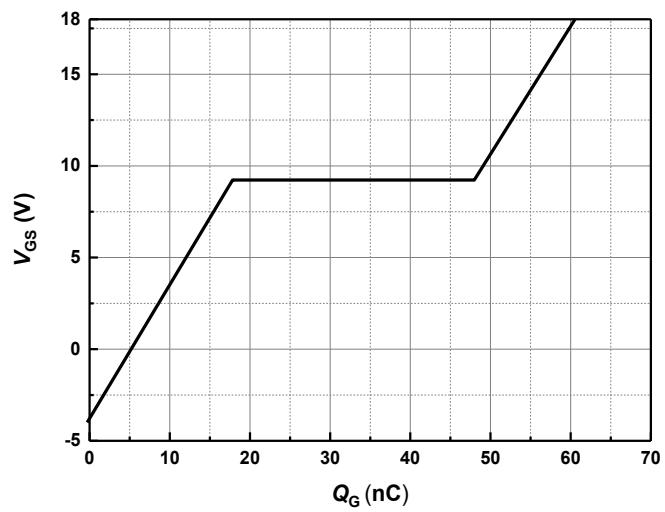
**Figure 10**    **Body Diode Characteristics at  $T_j=175^\circ\text{C}$**



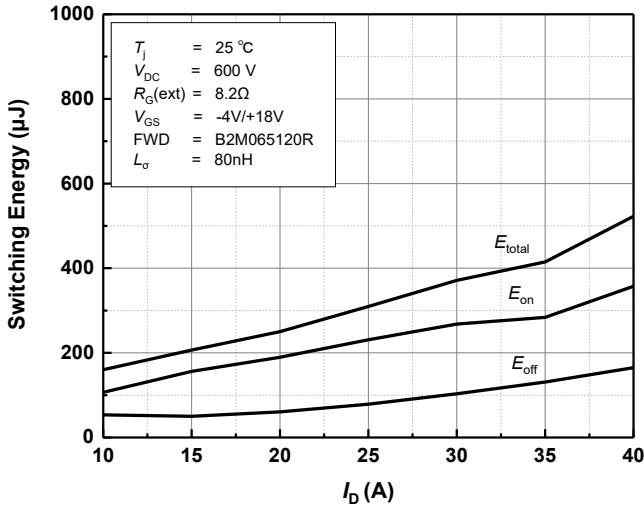
**Figure 11**    **3rd Quadrant Characteristics at  $T_j=25^\circ\text{C}$**



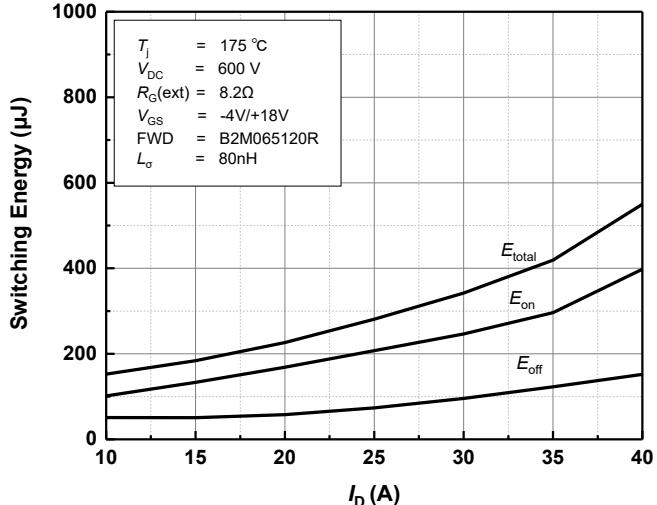
**Figure 12**    **3rd Quadrant Characteristics at  $T_j=175^\circ\text{C}$**

**Typical Performance**

**Figure 13** Output Capacitor stored Energy

**Figure 14** Maximum Power Dissipation Derating vs. Case Temperature

**Figure 15** Continuous Drain Current Derating vs. Case Temperature

**Figure 16** Gate Charge Characteristics

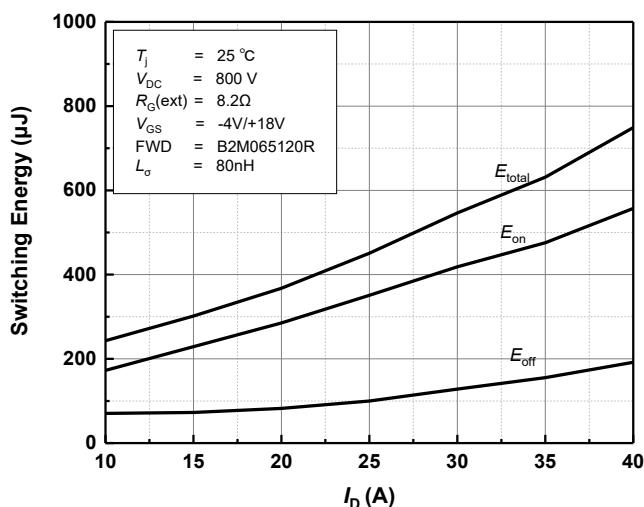
### Typical Performance



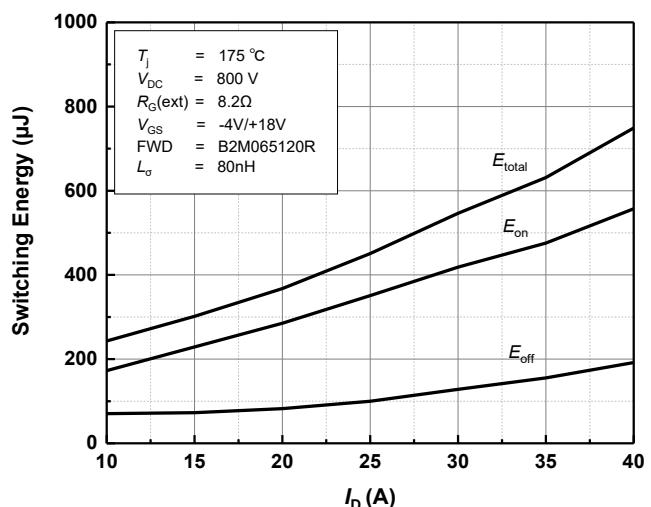
**Figure 17** Clamped Inductive Switching Energy vs. Drain Current ( $V_{DC} = 600V$ ) at  $T_j=25^\circ C$



**Figure 18** Clamped Inductive Switching Energy vs. Drain Current ( $V_{DC} = 600V$ ) at  $T_j=175^\circ C$

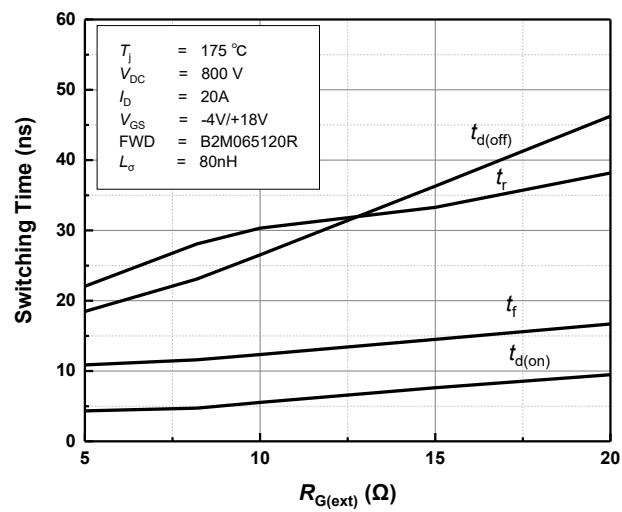
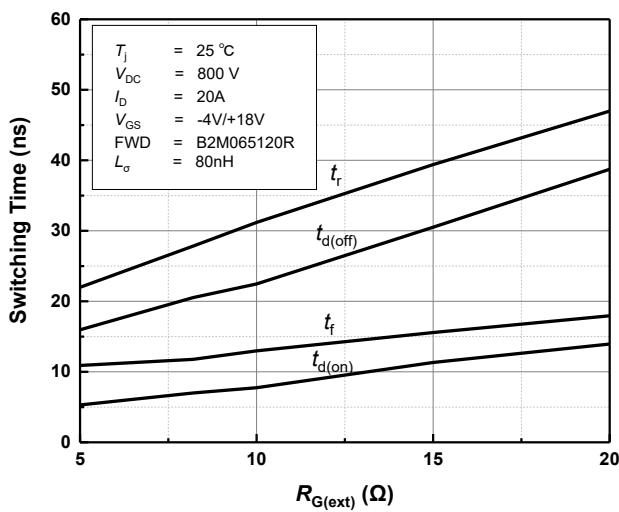
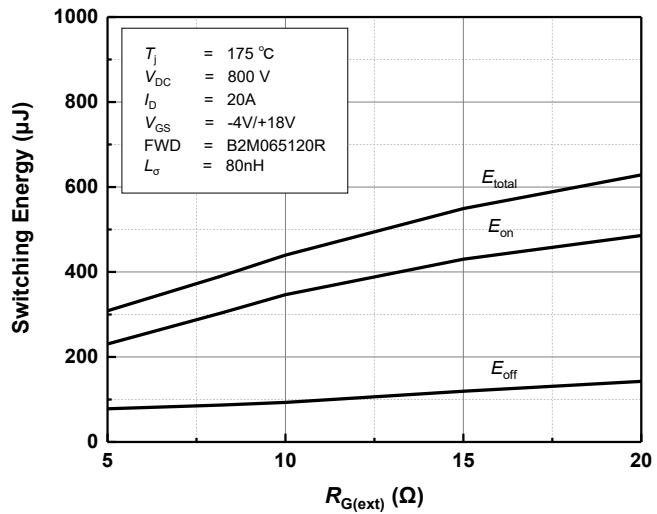
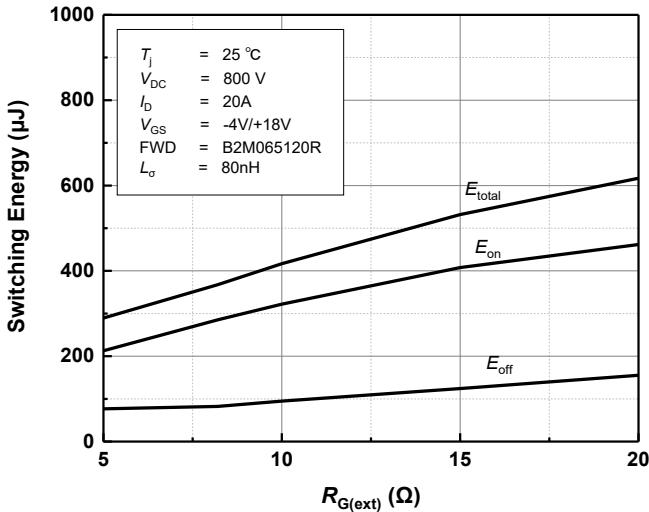


**Figure 19** Clamped Inductive Switching Energy vs. Drain Current ( $V_{DC} = 800V$ ) at  $T_j=25^\circ C$

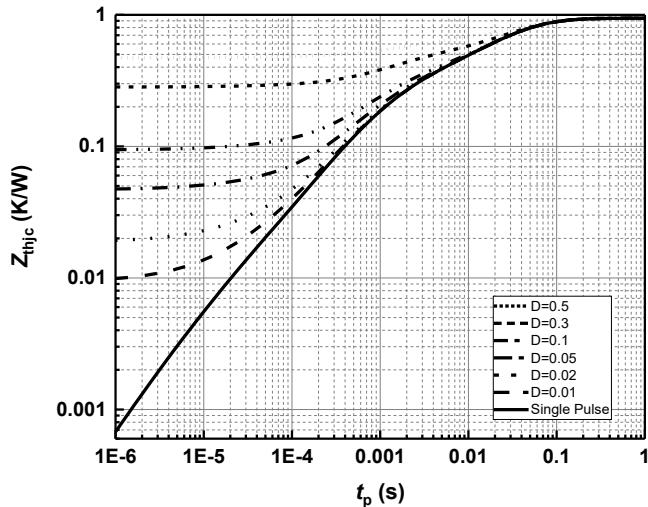


**Figure 20** Clamped Inductive Switching Energy vs. Drain Current ( $V_{DC} = 800V$ ) at  $T_j=175^\circ C$

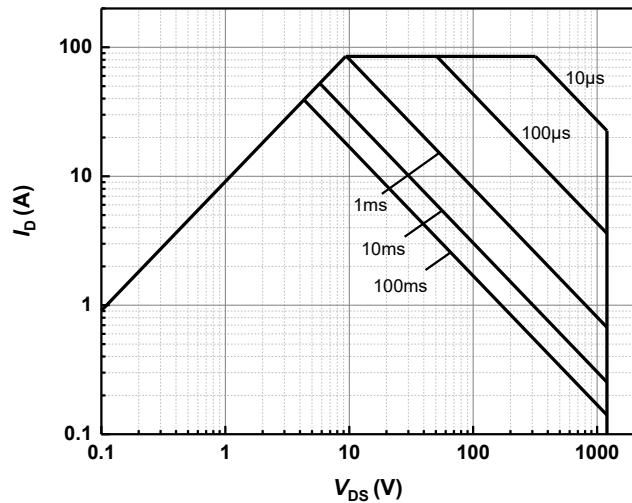
### Typical Performance



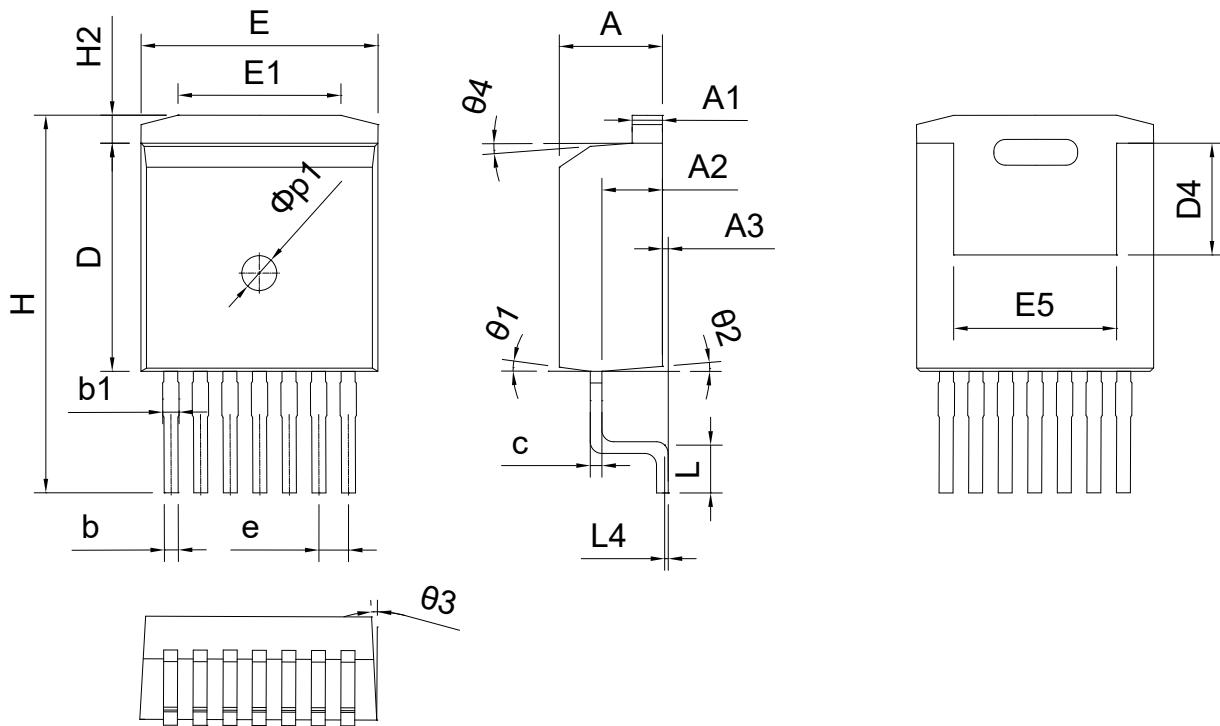
### Typical Performance



**Figure 25** Transient Thermal Impedance (Junction - Case)



**Figure 26** Forward Biased Safe Operating Area

**Package Dimensions**


SYMBOL	mm		
	MIN	NOM	MAX
A	4.30	4.43	4.56
A1	1.20	1.30	1.40
A2	2.45	2.60	2.75
A3	0.00	0.13	0.25
b	0.50	0.60	0.70
b1	0.60	0.70	0.90
c	0.45	0.50	0.60
D	8.93	9.08	9.23
D4	4.65	4.80	4.95
E	10.08	10.18	10.28
E1	6.50	7.00	7.50
E5	6.82	7.22	7.62
e	1.27 BSC		
H	15.00	15.50	16.00
H2	0.98	1.20	1.42
L	1.90	2.20	2.50
L4	0.25 BSC		
Φp1	1.40	1.50	1.60
θ1	3°	5°	7°
θ2	3°	5°	7°
θ3	3°	5°	7°
θ4	3°	5°	7°

## Revision History

Document Version	Date of Release	Description of Changes
Rev. 0.0	2023-06-05	Draft datasheet created.

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